

## 2N7002CK

# 60 V, 0.3 A N-channel Trench MOSFET Rev. 01 — 11 September 2009

**Product data sheet** 

## **Product profile**

#### 1.1 General description

ESD protected N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

#### 1.2 Features

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 3 kV

#### 1.3 Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage		-	-	60	V
I <sub>D</sub>	drain current		-	-	300	mA
I <sub>DM</sub>	peak drain current	single pulse; $t_p \le 10 \ \mu s$	-	-	1.2	Α
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V};$ $I_D = 500 \text{ mA}$	-	1.1	1.6	Ω



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017aaa000

## 2. Pinning information

Table 2. Pinning

	9			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source	3	D
3	D	drain	1 2	G T S

## 3. Ordering information

Table 3. Ordering information

Type number	Package	Package				
	Name	Description	Version			
2N7002CK	TO-236AB	plastic surface-mounted package; 3 leads	SOT23			

## 4. Marking

Table 4. Marking codes

Type number	Marking code <sup>[1]</sup>
2N7002CK	LP*

- [1] \* = -: made in Hong Kong
  - \* = p: made in Hong Kong
  - \* = t: made in Malaysia
  - \* = W: made in China

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## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	25 °C $\leq$ T <sub>j</sub> $\leq$ 150 °C	-	60	V
$V_{GS}$	gate-source voltage		-	±20	V
$I_D$	drain current	V <sub>GS</sub> = 10 V			
		T <sub>amb</sub> = 25 °C	-	300	mΑ
		T <sub>amb</sub> = 100 °C	-	190	mΑ
I <sub>DM</sub>	peak drain current	$T_{amb}$ = 25 °C; $t_p \le 10 \mu s$	-	1.2	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	<u>[1]</u> _	350	mW
Tj	junction temperature			150	°C
T <sub>amb</sub>	ambient temperature		-55	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C
Source-d	rain diode				
Is	source current	T <sub>amb</sub> = 25 °C	-	200	mΑ
I <sub>SM</sub>	peak source current	$T_{amb}$ = 25 °C; $t_p \le 10 \mu s$	-	1.2	Α
ElectroSt	tatic Discharge (ESD)				
V <sub>ESD</sub>	electrostatic discharge voltage	all pins; human body model; C = 100  pF; $R = 1.5  \text{k}\Omega$	-	3	kV

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

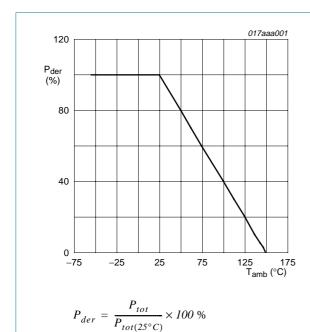
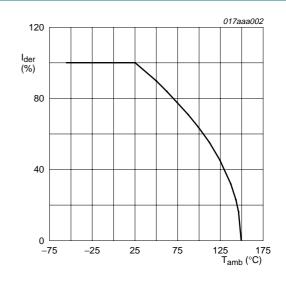


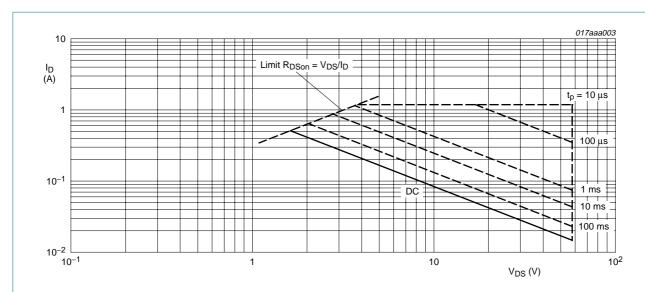
Fig 1. Normalized total power dissipation as a function of ambient temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

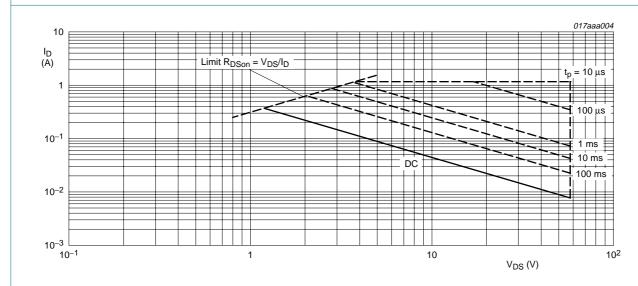
Fig 2. Normalized continuous drain current as a function of ambient temperature

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 $T_{sp}$  = 25 °C;  $I_{DM}$  = single pulse;  $V_{GS}$  = 10 V

Fig 3. Safe operating area; junction to solder point; continuous and peak drain currents as a function of drain-source voltage



 $T_{amb}$  = 25 °C;  $I_{DM}$  = single pulse;  $V_{GS}$  = 10 V

Fig 4. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

#### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	350	500	K/W

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 Table 6.
 Thermal characteristics ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	150	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

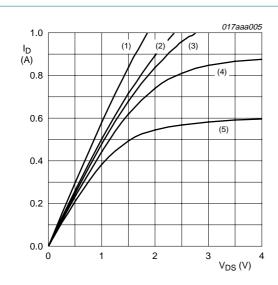
## 7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown	$I_D = 10 \mu A; V_{GS} = 0 V$				
	voltage	T <sub>j</sub> = 25 °C	60	-	-	V
		T <sub>j</sub> = −55 °C	55	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS};$ $T_j = 25 ^{\circ}C$	1	1.75	2.5	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}$				
		T <sub>j</sub> = 25 °C	-	-	100	nΑ
		T <sub>j</sub> = 150 °C	-	-	1	μΑ
$I_{GSS}$	gate leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	5	μΑ
		$V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$	-	50	450	nΑ
		$V_{GS} = \pm 5 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	100	nΑ
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V};$ $I_D = 200 \text{ mA}$				
		T <sub>j</sub> = 25 °C	-	1.3	3	Ω
		T <sub>j</sub> = 150 °C	-	2.8	4.4	Ω
		$V_{GS} = 10 \text{ V}; I_D = 500 \text{ mA}$	-	1.1	1.6	Ω
Dynamic o	characteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 200 \text{ mA};$	-	1.09	1.3	nC
$Q_{GS}$	gate-source charge	V <sub>DS</sub> = 10 V; V <sub>GS</sub> = 4.5 V	-	0.22	-	nC
$Q_{GD}$	gate-drain charge	VGS = 4.5 V	-	0.23	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$	-	47.2	55	pF
C <sub>oss</sub>	output capacitance	f = 1 MHz	-	11	20	pF
C <sub>rss</sub>	reverse transfer capacitance		-	5	7.5	pF
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 15 V;	-	8	15	ns
t <sub>r</sub>	rise time	$R_L = 15 \Omega;$	-	8	15	ns
t <sub>d(off)</sub>	turn-off delay time	$-V_{GS} = 10 \text{ V};$ $-R_G = 6 \Omega$	-	38	50	ns
t <sub>f</sub>	fall time	-	-	22	35	ns
Source-dr	ain diode					
$V_{SD}$	source-drain voltage	$I_S = 200 \text{ mA}; V_{GS} = 0 \text{ V}$	0.47	0.79	1.1	V

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(1) 
$$V_{GS} = 10 \text{ V}$$

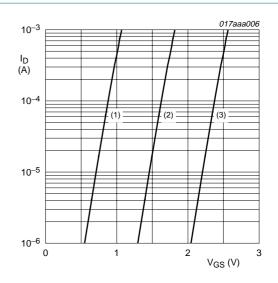
(2) 
$$V_{GS} = 5 \text{ V}$$

(3) 
$$V_{GS} = 4.5 \text{ V}$$

(4) 
$$V_{GS} = 4 V$$

(5) 
$$V_{GS} = 3.5 \text{ V}$$

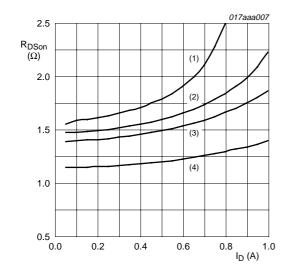
Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



$$T_{j} = 25 \,^{\circ}\text{C}; \, V_{DS} = 5 \,^{\circ}\text{V}$$

- (1) minimum values
- (2) typical values
- (3) maximum values





T<sub>i</sub> = 25 °C

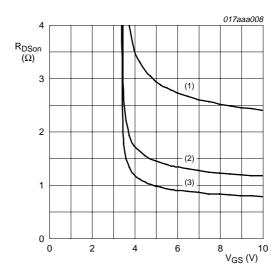
(1) 
$$V_{GS} = 4 V$$

(2) 
$$V_{GS} = 4.5 \text{ V}$$

(3) 
$$V_{GS} = 5 V$$

(4) 
$$V_{GS} = 10 \text{ V}$$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



 $I_D = 500 \text{ mA}$ 

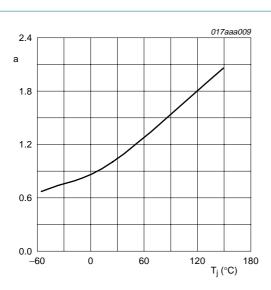
(1) 
$$T_j = 150 \, ^{\circ}C$$

(2) 
$$T_j = 25$$
 °C

(3) 
$$T_j = -55 \,^{\circ}\text{C}$$

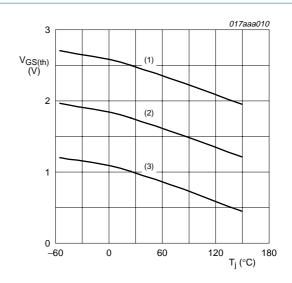
Fig 8. Drain-source on-resistance as a function of gate-source voltage; typical values

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$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

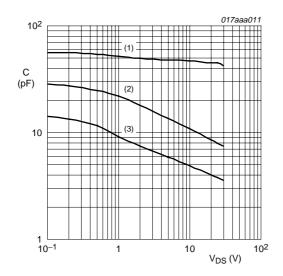
Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature



$$I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 10. Gate-source threshold voltage as a function of junction temperature



 $V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 

- (1) C<sub>iss</sub>
- (2) Coss
- (3) Crss

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

#### 60 V, 0.3 A N-channel Trench MOSFET

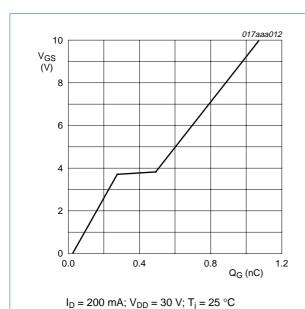
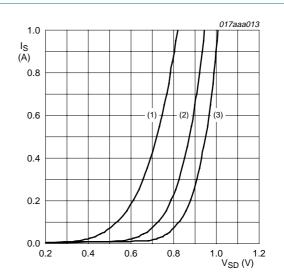


Fig 12. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0 V$ 

(1)  $T_j = 150 \, ^{\circ}C$ 

(2)  $T_j = 25 \, ^{\circ}C$ 

(3)  $T_j = -55 \,^{\circ}\text{C}$ 

Fig 13. Source current as a function of source-drain voltage; typical values

#### 60 V, 0.3 A N-channel Trench MOSFET

## 8. Package outline

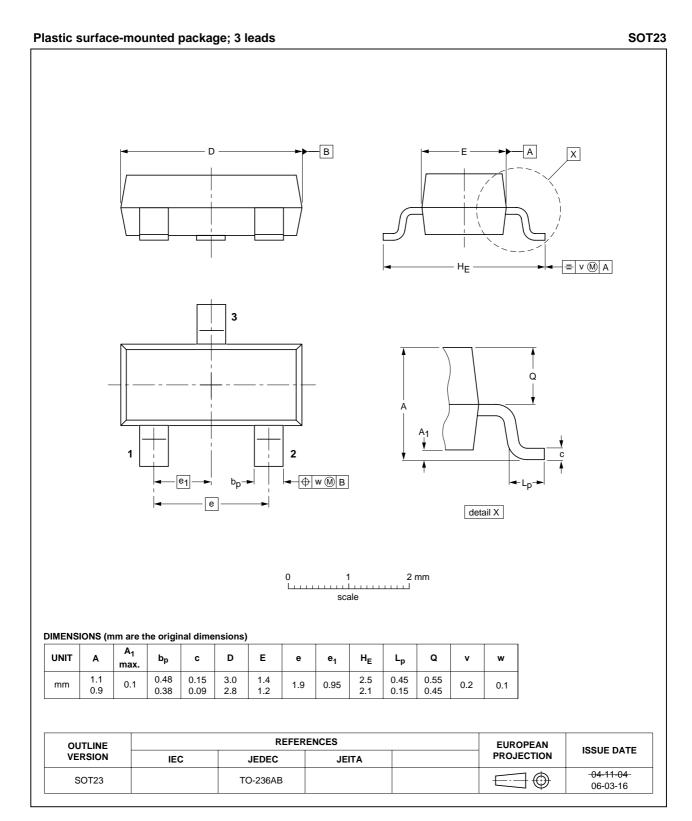
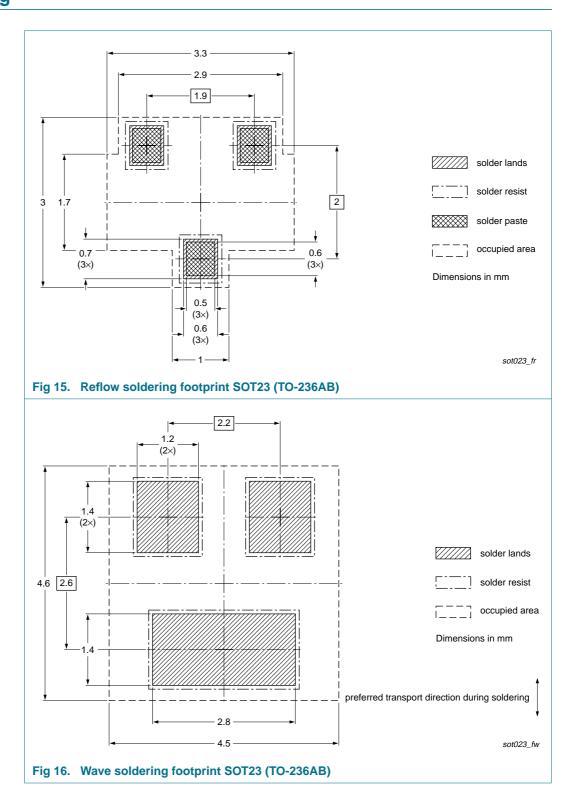


Fig 14. Package outline SOT23 (TO-236AB)

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## 9. Soldering



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## 10. Revision history

#### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
2N7002CK_1	20090911	Product data sheet	-	-

#### 60 V, 0.3 A N-channel Trench MOSFET

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#### 11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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